

General description

650V GaN-on-Silicon Enhancement-mode Power Transistor in Dual Flat No-lead Package (DFN) with 5 mm × 6 mm size.

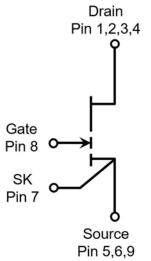
Features

- Enhancement-mode transistor normally-OFF power switch
- · Ultra-high switching frequency
- No reverse-recovery charge
- · Low gate charge, low output charge
- Qualified for industrial applications according to JEDEC Standards
- · ESD safeguard
- RoHS, Pb-free, REACH-compliant

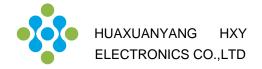
Applications

- · AC-DC converters
- DC-DC converters
- · Totem pole PFC
- Fast battery charging
- · High-density power conversion
- High-efficiency power conversion





Gate	8
Drain	1, 2, 3, 4
Kelvin Source	7
Source	5, 6, 9



Maximum ratings

at T_j = 25 °C unless otherwise specified. Continuous application of maximum ratings can deteriorate transistor lifetime. For further information, contact CloudSemi sales office.

Table 3 Maximum rating

Davamatara	Complete		Values		Unito	Notes/Test Conditions
Parameters	Symbols	Min.	Тур.	Max.	Units	
Drain-source voltage	V _{DS, max}	ı	-	650	V	V _{GS} = 0 V, I _D = 10 μA
Drain-source voltage transient ¹	V _{DS, transient}	-	-	750	V	V _{GS} = 0 V, V _{DS} = 750 V
Continuous current, drain-source	I _D	-	-	10	Α	T _c = 25 °C
Pulsed current, drain-source ²	I _D , pulse	-	-	18	Α	T _c = 25 °C; V _G = 6 V
Pulsed current, drain-source ²	I _{D, pulse}	-	-	10	Α	T _c = 125 °C; V _G = 6 V
Gate-source voltage, continuous ³	V _G S	-1.4	-	+7	V	T _j = -55 °C to 150 °C
Gate-source voltage, pulsed	VGS, pulse	1	-	+10	V	T_j = -55 °C to 150 °C; t_{Pulse} = 50 ns, f = 100 kHz; open drain
Power dissipation	P _{tot}	ı	-	75	W	T _c = 25 °C
Operating temperature	Tj	-55	-	+150	°C	
Storage temperature	T _{stg}	-55	-	+150	°C	

^{1.} $V_{DS,\,transient}$ is intended for surge rating during non-repetitive events, t_{Pulse} < 1 μs .

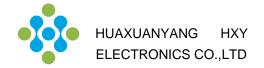
Thermal characteristics

Table 4 Thermal characteristics

Parameters	Symbols		Values		Units	Notes/Test Conditions
raidilleters	Syllibols	Min.	Тур.	Max.	Uiills	Notes/Test Conditions
Thermal resistance, junction-case	R _{thJC}	ı	-	1.65	°C/W	
Reflow soldering temperature	T _{sold}	-	-	260	°C	MSL3

^{2.} Pulse width = 10 μs.

^{3.} The minimum V_{GS} is clamped by ESD protection circuit, as shown in Figure 8.



Electrical characteristics

at T_j = 25 °C, unless specified otherwise.

Table 5 Static characteristics

Parameters	Cumbala	Values			11	No. 4 - 4 To a 4 O a selfer a se
	Symbols	Min.	Тур.	Max.	Units	Notes/Test Conditions
Cata threehold voltage	\/	1.2	1.6	2.5	V	I_D = 11 mA; V_{DS} = V_{GS} ; T_j = 25 °C
Gate threshold voltage	V _{GS(TH)}	-	1.6	-	V	I _D = 11 mA; V _{DS} = V _{GS} ; T _j = 125 °C
D :	IDSS	-	0.4	20	μΑ	V _{DS} = 650 V; V _{GS} = 0 V; T _j = 25 °C
Drain-source leakage current		-	4	-		V _{DS} = 650 V; V _{GS} = 0 V; T _j = 125 °C
Gate-source leakage current	Igss	-	-	200	μA	V _{GS} = 6 V; V _{DS} = 0 V
Drain-source on-state	D	-	160	200	mΩ	V _{GS} = 6 V; I _D = 3 A; T _j = 25 °C
resistance	R _{DS(on)}	-	330	-	mΩ	V _{GS} = 6 V; I _D = 3 A; T _j = 125 °C
Gate resistance	R _G	-	3.5	-	Ω	f = 5 MHz; open drain

Table 6 Dynamic characteristics

Damana 4	Values				11.24	N
Parameters	Symbols	Min.	Тур.	Max.	Units	Notes/Test Conditions
Input capacitance	C _{iss}	-	83	-	pF	V _{GS} = 0 V; V _{DS} = 400 V; f = 100 kHz
Output capacitance	Coss	-	27	-	pF	V _{GS} = 0 V; V _{DS} = 400 V; f = 100 kHz
Reverse transfer capacitance	Crss	-	0.4	-	pF	V _{GS} = 0 V; V _{DS} = 400 V; f = 100 kHz
Effective output capacitance, energy related ¹	C _{o(er)}	-	35	-	pF	V _{GS} = 0 V; V _{DS} = 0 to 400 V
Effective output capacitance, time related ²	C _{o(tr)}	-	54	-	pF	V _{GS} = 0 V; V _{DS} = 0 to 400 V
Output charge	Qoss	-	22	-	nC	V _{GS} = 0 V; V _{DS} = 0 to 400 V
Turn-on delay time	t _{d(on)}	-	2	-	ns	
Turn-off delay time	t _{d(off)}	-	4	-	ns	V _{DS} = 400 V; I _D = 6 A; L = 318 μH;
Rise time	tr	-	5	-	ns	$V_{GS} = 6 \text{ V}; R_{on} = 10 \Omega; R_{off} = 2 \Omega$
Fall time	t _f	-	6	-	ns	

^{1.} $C_{o(er)}$ is the fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 400 V.

^{2.} $C_{o(tr)}$ is the fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 400 V.

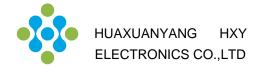


Table 7 Gate charge characteristics

Parameters	Values				Units	Notes/Test Conditions
raidilleters	Symbols	Min.	Тур.	Max.	Ullits	Notes/Test Conditions
Gate charge	Q _G	-	2.3	-	nC	\(\ - 0 \ta \C \\ \\ \\ \ \ \ \ \ \ \ \ \ \ \ \ \
Gate-source charge	Q _{GS}	-	0.2	-	nC	$V_{GS} = 0 \text{ to } 6 \text{ V}; V_{DS} = 400 \text{ V};$
Gate-drain charge	Q _{GD}	-	0.9	-	nC	I _D = 3 A
Gate plateau voltage	V _{Plat}	-	2.4	-	V	V _{DS} = 400 V; I _D = 3 A

Table 8 Reverse conduction characteristics

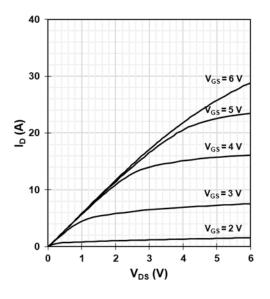
Domonostono	Complete and		Values			Nata (Tast Canditians
Parameters	Symbols	Min.	Typ. Max. Units	Units	Notes/Test Conditions	
Source-drain reverse voltage	V _{SD}	-	2.5	-	V	V _{GS} = 0 V; I _{SD} = 3 A
Pulsed current, reverse	Is, pulse	-	20	-	Α	V _{GS} = 6 V
Reverse recovery charge	Qrr	-	0	-	nC	I _{SD} = 3 A; V _{DS} = 400 V
Reverse recovery time	t _{rr}	-	0	-	ns	
Peak reverse recovery			0		Α	
current	Irrm	-	U	-	A	



Electrical characteristics diagrams

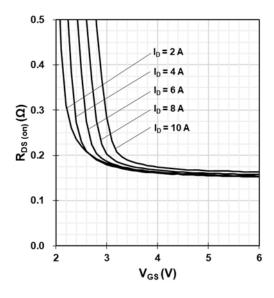
at T_j = 25 °C, unless specified otherwise.

Figure 1 Typ. output characteristics



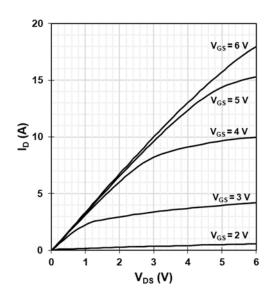
 I_D = f(V_{DS}, V_{GS}); T_j = 25 °C

Figure 3 Typ. drain-source on-state resistance



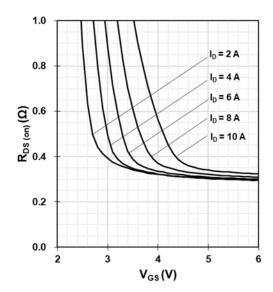
 $R_{DS(on)}$ = $f(I_{DS}, V_{GS})$; T_j = 25 °C

Figure 2 Typ. output characteristics



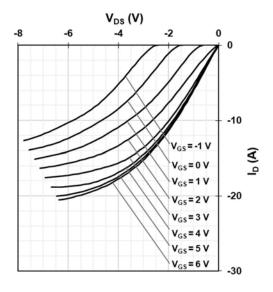
 $I_D = f(V_{DS}, V_{GS}); T_j = 125 \,^{\circ}C$

Figure 4 Typ. drain-source on-state resistance



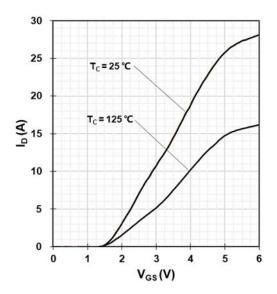
 $R_{DS(on)} = f(I_{DS}, V_{GS}); T_j = 125 \text{ }^{\circ}\text{C}$

Figure 5 Typ. channel reverse characteristics



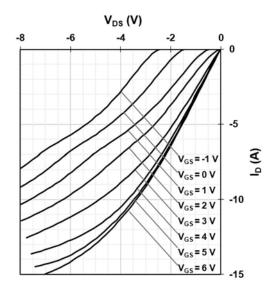
 $I_D = f(V_{DS}, V_{GS}); T_j = 25 \, ^{\circ}C$

Figure 7 Typ. transfer characteristics



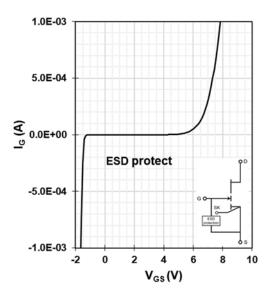
 $I_D = f(V_{GS}); V_{DS} = 5 V$

Figure 6 Typ. channel reverse characteristics



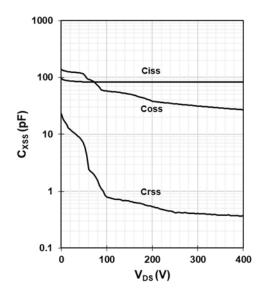
 $I_D = f(V_{DS}, V_{GS}); T_j = 125 \,^{\circ}C$

Figure 8 Typ. gate-to-source leakage



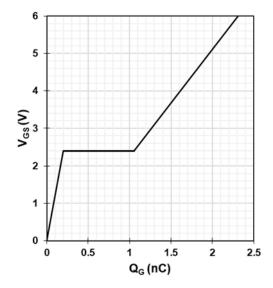
 $I_G = f(V_{GS})$; I_G reverse turn on by ESD unit; $V_D = open$

Figure 9 Typ. capacitances



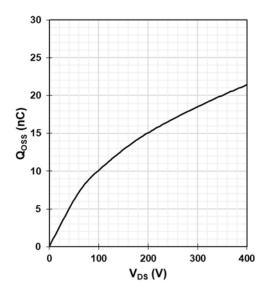
 $C_{XSS} = f(V_{DS})$; Freq. = 100 kHz

Figure 10 Typ. gate charge



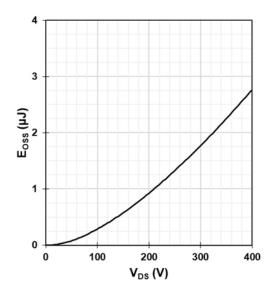
 $V_{GS} = f(Q_G)$; $V_{DC\text{-LINK}} = 400 \text{ V}$; $I_D = 3 \text{ A}$

Figure 11 Typ. output charge



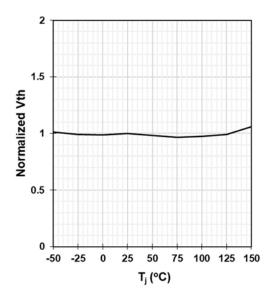
 $Q_{OSS} = f(V_{DS})$; Freq. = 100 kHz

Figure 12 Typ. Coss stored energy



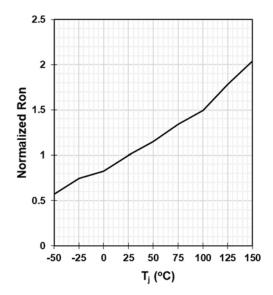
 $E_{OSS} = f(V_{DS})$; Freq. = 100 kHz

Figure 13 Gate threshold voltage



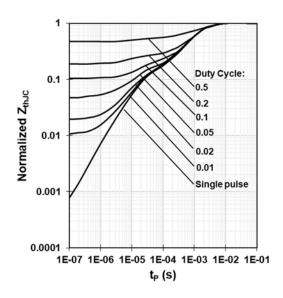
 $V_{TH} = f(T_j); \ V_{GS} = V_{DS}; \ I_D = 11 \ mA$

Figure 14 Drain-source on-state resistance



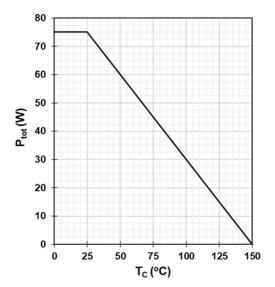
 $R_{DS(on)} = f(T_j); I_D = 3 A; V_{GS} = 6 V$

Figure 15 Max. transient thermal impedance



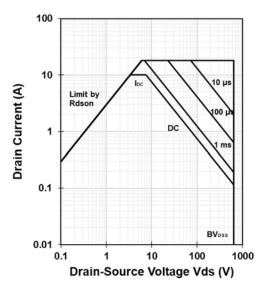
 $Z_{thJC} = f(t_P, D)$

Figure 16 Power dissipation



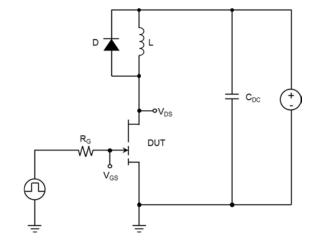
 $P_{tot} = f(T_C)$

Figure 17 Safe operating area



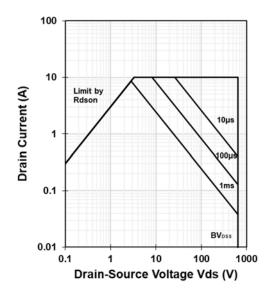
$$I_D = f(V_{DS}); T_C = 25 \, ^{\circ}C$$

Figure 19 Max. transient thermal impedance



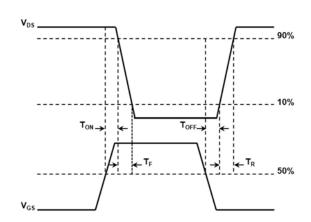
 $V_{DS} = 400~V,~I_D = 6~A,~L = 318~\mu H,~V_{GS} = 6~V,$ $R_{on} = 10~\Omega,~R_{off} = 2~\Omega$

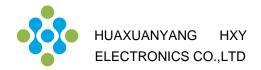
Figure 18 Safe operating area



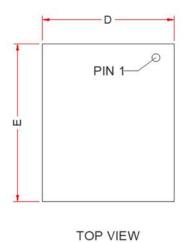
$$I_D = f(V_{DS}); T_C = 125 \,^{\circ}C$$

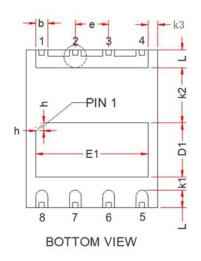
Figure 20 Typ. switching times waveform

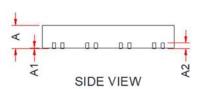


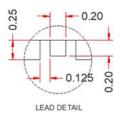


Package outlines

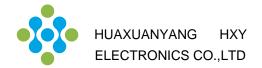




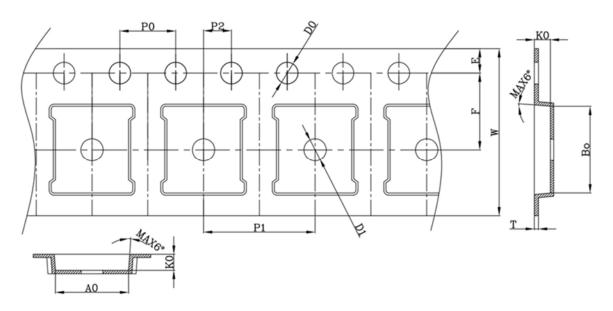




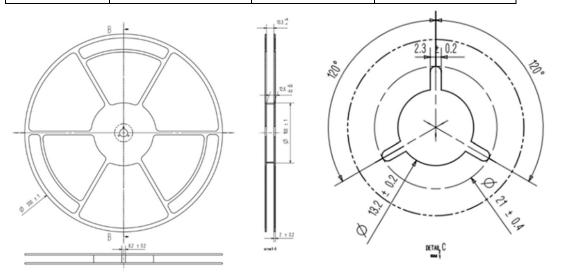
	MIN	MID	MAX				
Α	0.75	0.85	0.95				
A1	0.00	0.02	0.05				
A2		0.203REF					
b	0.40	0.45	0.50				
D	4.90	5.00	5.10				
D1	4.16	4.26	4.36				
E	5.90	6.00	6.10				
E1	1.95	2.05	2.15				
h	0.20	0.30	0.40				
L	0.575	0.675	0.775				
е	1.270BSC						
k1	0.400MIN						
k2	2.000MIN						
k3	0.270MIN						

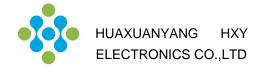


Reel information



SYMBOL	DIMENSION	SYMBOL	DIMENSION
W	12.00±0.30	10P0	40.00±0.20
E	1.75±0.10	P1	8.00±0.10
F	5.50±0.05	A0	5.25±0.10
D0	1.55±0.05	В0	6.25±0.10
D1	1.55±0.10	K0	1.15±0.10
P0	4.00±0.10	Т	0.25±0.05
P2	2.00±0.05		





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